

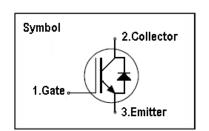
#### IGBT 内绝缘

#### **Features**

- 1200V,15A
- $V_{CE(sat)(typ.)}$ =1.9V @ $V_{GE}$ =15V, $I_{C}$ =15A
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA



JIAEN Trench IGBTs offer lower losses and higher energy efficiency for application such as IH (induction heating),UPS, general inverter and other soft switching applications.



#### **Absolute Maximum Ratings**

Symbol	Parameter	Value	Units
Vces	Collector-Emitter Voltage	1200	V
V <sub>GES</sub>	Gate-Emitter Voltage	<u>+</u> 30	V
l.	Continuous Collector Current (T <sub>C</sub> =25 °C)	30	А
lc	Continuous Collector Current (Tc=100°C)	15	А
Ісм	Pulsed Collector Current (Note 1)	45	А
lf	Diode Continuous Forward Current (T <sub>C</sub> =100 °C)	15	А
I <sub>FM</sub>	Diode Maximum Forward Current (Note 1)	45	А
t <sub>sc</sub>	Short Circuit Withstand Time	10	us
D-	Maximum Power Dissipation (T <sub>C</sub> =25 °C)	95	W
P <sub>D</sub>	Maximum Power Dissipation (Tc=100°C)	38	W
TJ	Operating Junction Temperature Range	-40 to +150	°C
T <sub>STG</sub>	Storage Temperature Range	-50 to +150	°C

## **Thermal Characteristics**

Symbol	Parameter	Max.	Units
R <sub>th j-c</sub>	Thermal Resistance, Junction to case for IGBT	1.3	°C/ W
R <sub>th j-c</sub>	Thermal Resistance, Junction to case for Diode	1.95	°C/ W
R <sub>th j-a</sub>	Thermal Resistance, Junction to Ambient	40	°C/ W



## **Electrical Characteristics** (Tc=25°C unless otherwise noted )

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250uA$	1200	-	-	V
I <sub>CES</sub>	Collector-Emitter Leakage Current	V <sub>CE</sub> = 1200V, V <sub>GE</sub> = 0V	-	-	100	uA
1	Gate Leakage Current, Forward $V_{GE}$ =30V, $V_{CE}$ = 0V		-	-	100	nA
I <sub>GES</sub>	Gate Leakage Current, Reverse	$V_{GE}$ = -30V, $V_{CE}$ = 0V	-	-	100	nA
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 250uA$	4.5	-	6.5	V
$V_{\text{CE(sat)}}$	Collector-Emitter Saturation Voltage	V <sub>GE</sub> =15V, I <sub>C</sub> = 15A	1	1.9	2.4	V
Qg	Total Gate Charge	Vcc=600V	-	120		nC
Q <sub>ge</sub>	Gate-Emitter Charge	V <sub>GE</sub> =15V	-	50		nC
Q <sub>gc</sub>	Gate-Collector Charge	Ic=15A	-	15		nC
t <sub>d(on)</sub>	Turn-on Delay Time		-	20	-	ns
t r	Turn-on Rise Time	Vcc=600V	-	30	-	ns
t d(off)	Turn-off Delay Time	V <sub>GE</sub> =15V	-	150	-	ns
t f	Turn-off Fall Time	Ic=15A R <sub>G</sub> =10Ω	-	95	-	ns
Eon	Turn-on Switching Loss	Inductive Load	-	2.8	-	mJ
Eoff	Turn-off Switching Loss	Tc=25 ℃	-	0.6	-	mJ
Ets	Total Switching Loss		-	3.4	-	mJ
Cies	Input Capacitance	V <sub>CF</sub> =25V	-	2300	-	pF
C <sub>oes</sub>	Output Capacitance	V <sub>GE</sub> =0V	-	95	-	pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1MHz	-	45	-	pF

# Electrical Characteristics of Diode (Tc=25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> =15A		1.9	2.6	V
trr	Diode Reverse Recovery Time	V <sub>CE</sub> = 600V	•	230		ns
Irr	Diode peak Reverse Recovery Current	I <sub>F</sub> = 15A	-	27		Α
Qrr	Diode Reverse Recovery Charge	dlF/dt = 200A/us		1260		nC

#### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature



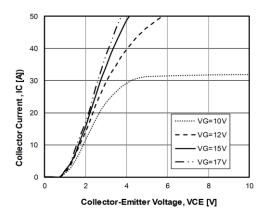


Fig 1. Output characteristics

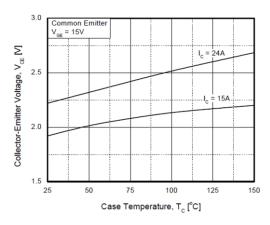


Figure 3. Saturation Voltage vs. Case Temperature at Variant Current Level

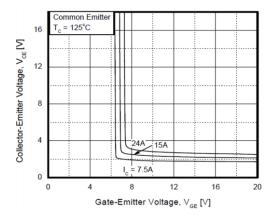


Figure 5. Saturation Voltage vs. VGE

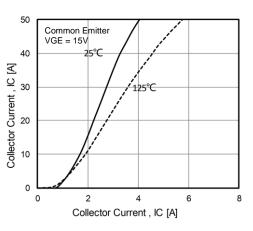


Fig 2. Typical Saturation Voltage Characteristics

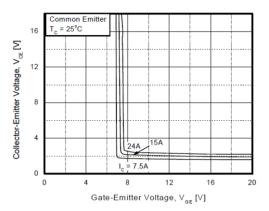


Figure 4. Saturation Voltage vs. VGE

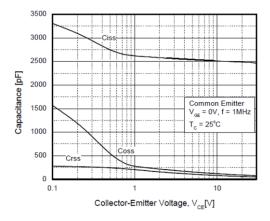


Figure 6. Capacitance Characteristics



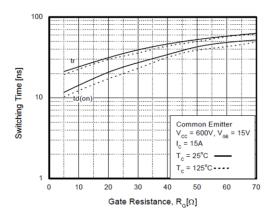


Figure 7. Turn-On Characteristics vs. Gate Resistance

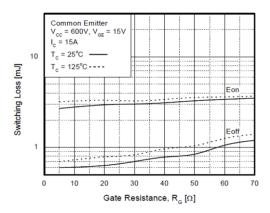


Figure 9. Switching Loss vs. Gate Resistance

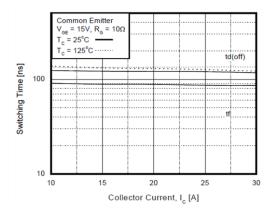


Figure 11. Turn-Off Characteristics vs. Collector Current

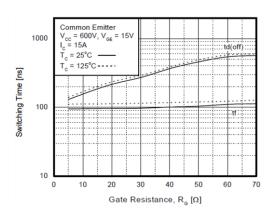


Figure 8. Turn-Off Characteristics vs. Gate Resistance

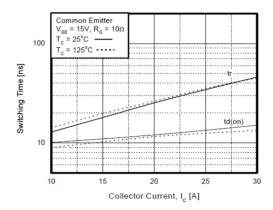


Figure 10. Turn-On Characteristics vs. Collector Current

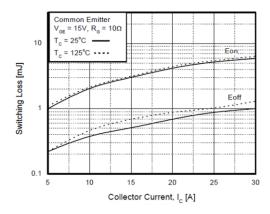


Figure 12. Switching Loss vs. Collector Current



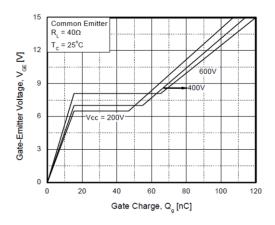


Figure 13. Gate Charge Characteristics

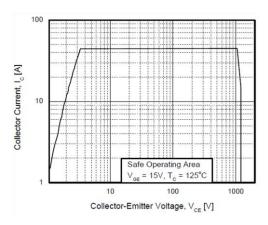


Figure 15. Turn-Off SOA

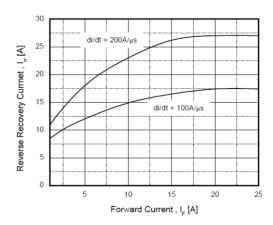


Figure 17. Reverse Recovery Current

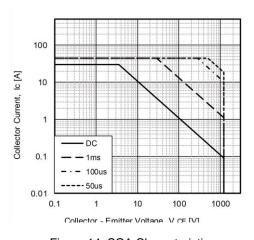


Figure 14. SOA Characteristics

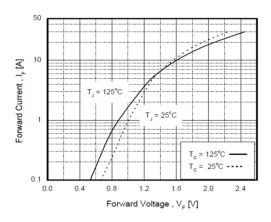


Figure 16. Forward Characteristics

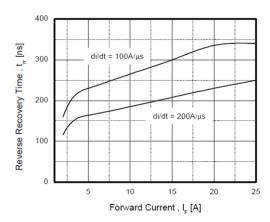
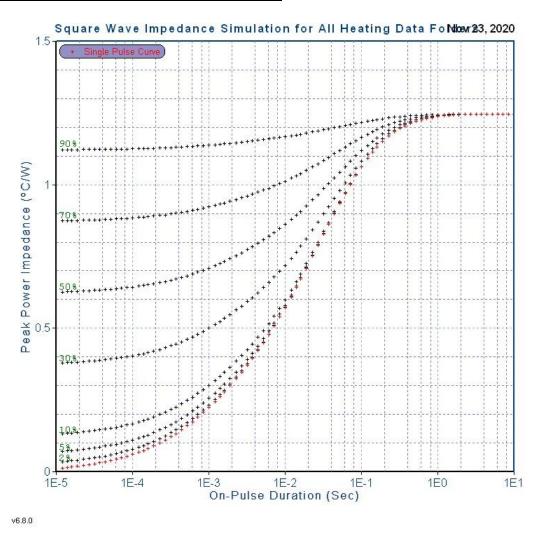


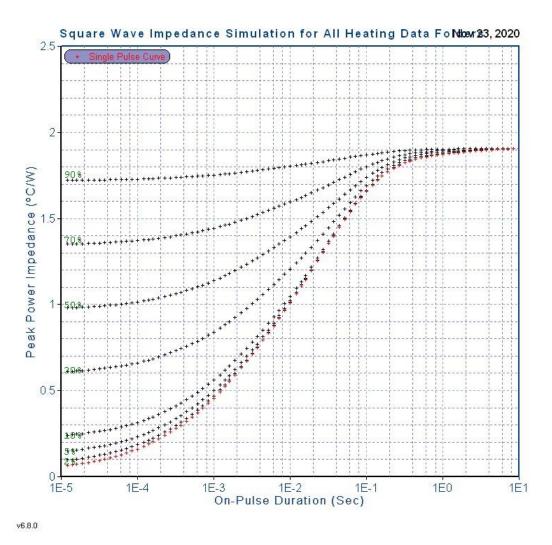
Figure 18. Reverse Recovery Time





Transient Thermal Impedance of IGBT



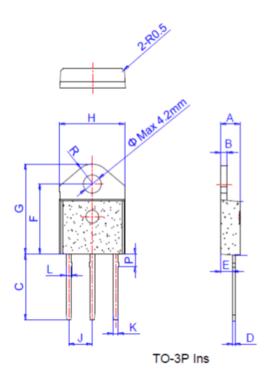


Transient Thermal Impedance of FRD

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#### **TO3P-3L-II PACKAGE OUTLINE**



	Dimensions						
Ref.	Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
Α	4.40		4.60	0.173		0.181	
В	1.45		1.55	0.057		0.061	
С	14.35		15.60	0.565		0.614	
D	0.50		0.70	0.020		0.028	
E	2.70		2.90	0.106		0.114	
F	15.80		16.50	0.622		0.650	
G	20.40		21.10	0.803		0.831	
Н	15.10		15.50	0.594		0.610	
J	5.40		5.65	0.213		0.222	
K	1.10		1.40	0.043		0.055	
L	1.35		1.50	0.053		0.059	
Р	2.80		3.00	0.110		0.118	
R		4.35			0.171		



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